Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/805,887	LAROIA ET AL.
Examiner	Art Unit
Steven HD Nguyen	2665

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SEARCHED						
Class	Subclass	Date	Examiner			
370	203-210	7/5/2005	ST			
375	260-261					
	270, 296					
	298, 301					
	346, 348					
	·					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST IFFT and interpolator	7/5/2005	ST
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